

<b>Notice of References Cited</b>	Application/Control No. 10/808,172	Applicant(s)/Patent Under Reexamination SCHOLTE, ALEXANDER M.	
	Examiner Abdullah Riyami	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0097798 A1	07-2002	Manor, Yehuda	375/240.02
*	B	US-2004/0139088 A1	07-2004	Mandato et al.	707/100
*	C	US-2005/0216776 A1	09-2005	Watanabe, Hideyuki	713/300
*	D	US-2005/0207340 A1	09-2005	O'Neill, Alan	370/230
*	E	US-6,967,927 B1	11-2005	Dugeon et al.	370/236.1
*	F	US-2006/0114889 A1	06-2006	Schneider et al.	370/352
*	G	US-2006/0168337 A1	07-2006	Stahl et al.	709/240
*	H	US-2006/0182117 A1	08-2006	Chen et al.	370/395.5
*	I	US-2006/0233333 A1	10-2006	Brombal et al.	379/114.2
*	J	US-7,126,939 B2	10-2006	Barany et al.	370/352
*	K	US-2006/0256719 A1	11-2006	Hsu et al.	370/230
*	L	US-2007/0242677 A1	10-2007	Shaheen et al.	370/395.21
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.